

	TEST REPORT						
FCC ID:	2AX2R-FI-EVATW						
Test Report No::	TCT220406E014						
Date of issue::	Apr. 21, 2022						
Testing laboratory:	SHENZHEN TONGCE TESTING LAB						
Testing location/ address:	TCT Testing Industrial Park Fuqiao 5th Industrial Zone, Fuhai Street, Bao'an District Shenzhen, Guangdong, 518103, People's Republic of China						
Applicant's name::	final Inc.						
Address::	4-44-1, Nakasaiwai-cho, Saiwai-Ku, Kawasaki-shi, Kanagawa, 212-0012, Japan						
Manufacturer's name:	SHENZHEN SHI KISB ELECTRONIC CO., LTD.						
Address::	F4, 5, BlockB, F3, Building A, Shanghe Industrial Park, Nanchang Village, Hangcheng Avenue, Xixiang Town, Bao'an District, Shenzhen City, Guangdong Province, China. (Zip Code: 518000)						
Standard(s):	FCC CFR Title 47 Part 1.1307						
Test item description:	True Wireless Earphone						
Trade Mark:	final						
Model/Type reference:	FI-EVATW, EVATWREI, EVATWNV, EVATW01, EVWTW02, EVATW06						
Rating(s)::	Rechargeable Li-ion Battery DC 3.7V						
Date of receipt of test item	Mar. 06, 2022						
Date (s) of performance of test:	Mar. 06, 2022 - Apr. 21, 2022						
Tested by (+signature):	Onnado YE						
Check by (+signature):	Beryl ZHAO						
Approved by (+signature):	Tomsin Joms in 18						

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# 1. General Product Information

# 1.1. EUT description

Test item description:	True Wireless Earphone	(3)	
Model/Type reference:	FI-EVATW		
Sample Number:	TCT220406E013-0101		
Operation Frequency:	2402MHz~2480MHz		
Modulation Type:	GFSK, π/4-DQPSK, 8DPSK		
Antenna Type:	Chip Antenna		
Antenna Gain:	5.22dBi		
Rating(s):	Rechargeable Li-ion Battery DC	3.7V	

Note: The antenna gain listed in this report is provided by applicant, and the test laboratory is not responsible for this parameter.

# 1.2. Model(s) list

No.	No. Model No.		
1	FI-EVATW		
Other models	EVATWREI, EVATWNV, EVATW01, EVWTW02, EVATW06		

Note: FI-EVATW is tested model, other models are derivative models. The models are identical in circuit and PCB layout, only different on the model names. So the test data of FI-EVATW can represent the remaining models.





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# 2. General Information

### 2.1. Test environment and mode

Item	Normal condition						
Temperature		+25°C					
Voltage	(ci)	DC 3.7V	(0)				
Humidity		56%					
Atmospheric Pressure:	(c')	1008 mbar	(c <sup>*</sup> )	(C			
Test Mode:							
Engineering mode:	Keep the EUT	in continuous transmi	tting by select channe	el			

# 2.2. Description of Support Units

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Equipment Model No.		Serial No.	FCC ID	Trade Name		
1		1	1	1		

#### Note:

- 1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
- 2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.
- 3. For conducted measurements (Output Power, 20dB Occupied Bandwidth, Carrier Frequencies Separation, Hopping Channel Number, Dwell Time, Spurious Emissions), the antenna of EUT is connected to the test equipment via temporary antenna connector, the antenna connector is soldered on the antenna port of EUT, and the temporary antenna connector is listed in the Test Instruments.



TESTING CENTRE TECHNOLOGY Report No.: TCT220406E014

## 3. Facilities and Accreditations

#### 3.1. Facilities

The test facility is recognized, certified, or accredited by the following organizations:

• FCC - Registration No.: 645098

SHENZHEN TONGCE TESTING LAB

**Designation Number: CN1205** 

The testing lab has been registered and fully described in a report with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files.

IC - Registration No.: 10668A-1

SHENZHEN TONGCE TESTING LAB

CAB identifier: CN0031

The testing lab has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing.

### 3.2. Location

SHENZHEN TONGCE TESTING LAB

Address: TCT Testing Industrial Park Fuqiao 5th Industrial Zone, Fuhai Street, Bao'an

District Shenzhen, Guangdong, 518103, People's Republic of China

TEL: +86-755-27673339





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## 4. Test Results and Measurement Data

According to §15.247(i) and §1.1307b(1), systems operating under the provisions of this section shall be operated in a manner that ensures that the public is not exposed to radio frequency energy level in excess of the commission's guidance.

The 1-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)]  $\cdot [\sqrt{f(GHz)}] \le 3.0$  for 1-g SAR, where

- f(GHz) is the RF channel transmit frequency in GHz
- Power and distance are rounded to the nearest mW and mm before calculation
- When the minimum test separation distance is < 5 mm, a distance of 5 mm according is applied to determine SAR test exclusion.
- The result is rounded to one decimal place for comparison

#### For BDR+EDR:

	Channel	Frequency (GHz)	Max. Power (dBm)	Tune up Power (dBm)	Max. Tune up Power (dBm)	Max. Tune up Power (mW)	Test distance (mm)	Result	exclusion thresholds for 1-g SAR
I	CH 0	2.402	2.56	2±1	3	2.00	5	0.62	3.0

#### Result:

Base on the calculation value, No SAR measurement is required.

